

N-Channel Enhancement Mode Field Effect Transistor

General Description

The 100N08A uses advanced trench technology and design to provide excellent RDS(ON). This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

Features

- N-channel-Enhancement mode
- Lower On-resistance
- 100% Avalanche Tested
- RoHS Compliant

Product Summary

BVDSS	RDSON	ID
80V	6mΩ	100A

Applications

- DC-DC converters
- Power switching application
- Ideal for high-frequency switching and synchronous rectification

TO-252/251 Pin Configuration



Туре	Package	Marking		
CMD100N08A	TO-252	CMD100N08A		
CMU100N08A	TO-251	CMU100N08A		

Absolute Maximum Ratings

Symbol	Parameter	Value	Units	
V_{DS}	Drain-Source Voltage 80		V	
V_{GS}	Gate-Source Voltage	±20	V	
I _D @T _C =25℃	Continuous Drain Current	Continuous Drain Current 100		
I _D @T _C =100℃	Continuous Drain Current 70		А	
I _{DM}	Pulsed Drain Current	400	А	
EAS	Single Pulse Avalanche Energy 185		mJ	
P _D @T _C =25°C	Total Power Dissipation 100		W	
T _{STG}	Storage Temperature Range -55 to 175		$^{\circ}$	
TJ	Operating Junction Temperature Range -55 to 175		$^{\circ}$	

Thermal Data

Symbol	Parameter	Value	Unit	
$R_{\theta JA}$	Thermal Resistance Junction-ambient	40	°C/W	
R _{eJC}	Thermal Resistance Junction-case	1.5	°C/W	

CMD100N08A/CMU100N08A



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Electrical Characteristics ($T_J=25^{\circ}$ C , unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V_{GS} =0 V , I_D =500 μA	80			V
D	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =28			6	0
R _{DS(ON)}		V_{GS} =6 V , I_D =25 A			11	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	2		3.5	V
	Drain-Source Leakage Current	V _{DS} =80V, V _{GS} =0V, T _J =25℃			1	- uA
I _{DSS}		V _{DS} =64V , V _{GS} =0V , T _J =125℃			100	
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V, V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =10V, I _D =25A		20		S
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		2.2		Ω
Qg	Total Gate Charge	I _D =30A		120		
Q_gs	Gate-Source Charge	V _{DS} =30V		25		nC
Q_{gd}	Gate-Drain Charge	V _{GS} = 10V		45		
$T_{d(on)}$	Turn-On Delay Time	V _{DS} =30V		20		
T _r	Rise Time	R _{GEN} =2.55Ω		18		no
T _{d(off)}	Turn-Off Delay Time	V _{GS} =10V		67		ns
T_f	Fall Time	R _L =15Ω		25		
C _{iss}	Input Capacitance			4000		
C _{oss}	Output Capacitance	V _{DS} =25V , V _{GS} =0V , f=1MHz		400		pF
C _{rss}	Reverse Transfer Capacitance			365		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			100	Α
I _{SM}	Pulsed Source Current				400	Α
V_{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =28A ,T _J =25℃			1.2	V

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